Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/774,389	UEMURA, TOSHIYA
Examiner	Art Unit
Wai-Sing Louie	2814

SEARCHED					
Class	Subclass	Date	Examiner		
257	79-103	3/3/2005	WSL		
		-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
LED, flig-chip, encapsulation, reflector, phosphor, light diffusion	3/3/2005	WSL		
		<u> </u>		